

## NCE N-Channel Enhancement Mode Power MOSFET

### Description

The NCE6020AI uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

### General Features

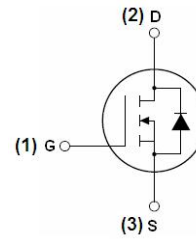
- $V_{DS} = 60V, I_D = 20A$   
 $R_{DS(ON)} < 25m\Omega @ V_{GS} = 10V$   
 $R_{DS(ON)} < 31m\Omega @ V_{GS} = 4.5V$
- High density cell design for ultra low  $R_{dson}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high  $E_{AS}$
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

### Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

**100% UIS TESTED!**

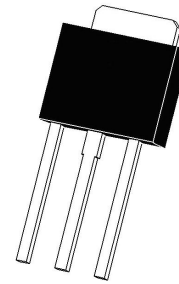
**100%  $\Delta V_{ds}$  TESTED!**



Schematic diagram



Marking and pin assignment



TO-251 top view

### Package Marking and Ordering Information

| Device Marking | Device    | Device Package | Reel Size | Tape width | Quantity |
|----------------|-----------|----------------|-----------|------------|----------|
| NCE6020AI      | NCE6020AI | TO-251         | -         | -          | -        |

### Absolute Maximum Ratings ( $T_C = 25^\circ C$ unless otherwise noted)

| Parameter  | Symbol             | Limit      | Unit          |
|--|--------------------|------------|---------------|
| Drain-Source Voltage                             | $V_{DS}$           | 60         | V             |
| Gate-Source Voltage                              | $V_{GS}$           | $\pm 20$   | V             |
| Drain Current-Continuous                         | $I_D$              | 20         | A             |
| Drain Current-Continuous( $T_C = 100^\circ C$ )  | $I_D(100^\circ C)$ | 14         | A             |
| Pulsed Drain Current                             | $I_{DM}$           | 60         | A             |
| Maximum Power Dissipation                        | $P_D$              | 45         | W             |
| Derating factor                                  |                    | 0.3        | W/ $^\circ C$ |
| Single pulse avalanche energy (Note 5)           | $E_{AS}$           | 72         | mJ            |
| Operating Junction and Storage Temperature Range | $T_J, T_{STG}$     | -55 To 175 | $^\circ C$    |

## Thermal Characteristic

|  |                 |     |                             |
|--|-----------------|-----|-----------------------------|
| Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup> | $R_{\theta JC}$ | 3.3 | $^{\circ}\text{C}/\text{W}$ |
|--|-----------------|-----|-----------------------------|

## Electrical Characteristics ( $T_C=25^{\circ}\text{C}$ unless otherwise noted)

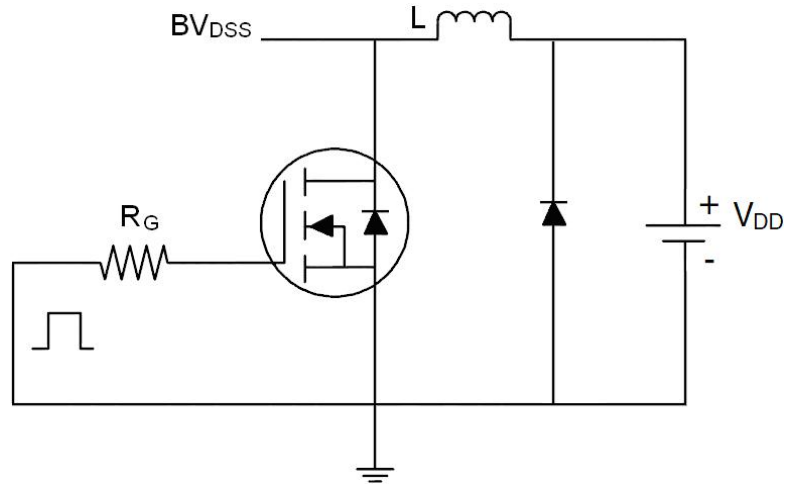
| Parameter  | Symbol       | Condition   | Min | Typ   | Max       | Unit       |
|--|--------------|---|-----|-------|-----------|------------|
| <b>Off Characteristics</b>                           |              |   |     |       |           |            |
| Drain-Source Breakdown Voltage                       | $BV_{DSS}$   | $V_{GS}=0V, I_D=250\mu A$   | 60  | -     | -         | V          |
| Zero Gate Voltage Drain Current                      | $I_{DSS}$    | $V_{DS}=60V, V_{GS}=0V$   | -   | -     | 1         | $\mu A$    |
| Gate-Body Leakage Current                            | $I_{GSS}$    | $V_{GS}=\pm 20V, V_{DS}=0V$   | -   | -     | $\pm 100$ | nA         |
| <b>On Characteristics</b> <sup>(Note 3)</sup>        |              |   |     |       |           |            |
| Gate Threshold Voltage                               | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=250\mu A$   | 1.2 | 1.6   | 2.5       | V          |
| Drain-Source On-State Resistance                     | $R_{DS(on)}$ | $V_{GS}=10V, I_D=20A$   | -   | 21    | 25        | m $\Omega$ |
|  |              | $V_{GS}=4.5V, I_D=20A$  |     | 25.5  | 31        |            |
| Forward Transconductance                             | $g_{FS}$     | $V_{DS}=5V, I_D=5A$   | 11  | -     | -         | S          |
| <b>Dynamic Characteristics</b> <sup>(Note 4)</sup>   |              |   |     |       |           |            |
| Input Capacitance                                    | $C_{iss}$    | $V_{DS}=30V, V_{GS}=0V,$<br>$F=1.0\text{MHz}$                                     | -   | 973.2 | -         | PF         |
| Output Capacitance                                   | $C_{oss}$    |   | -   | 61.2  | -         | PF         |
| Reverse Transfer Capacitance                         | $C_{rss}$    |   | -   | 58.8  | -         | PF         |
| <b>Switching Characteristics</b> <sup>(Note 4)</sup> |              |   |     |       |           |            |
| Turn-on Delay Time                                   | $t_{d(on)}$  | $V_{DD}=30V, I_D=2A, R_L=6.7\Omega$<br>$V_{GS}=10V, R_G=3\Omega$                  | -   | 5     | -         | nS         |
| Turn-on Rise Time                                    | $t_r$        |   | -   | 2.6   | -         | nS         |
| Turn-Off Delay Time                                  | $t_{d(off)}$ |   | -   | 16.1  | -         | nS         |
| Turn-Off Fall Time                                   | $t_f$        |   | -   | 2.3   | -         | nS         |
| Total Gate Charge                                    | $Q_g$        | $V_{DS}=30V, I_D=4.5A,$<br>$V_{GS}=10V$   | -   | 25    | -         | nC         |
| Gate-Source Charge                                   | $Q_{gs}$     |   | -   | 4.5   | -         | nC         |
| Gate-Drain Charge                                    | $Q_{gd}$     |   | -   | 6.5   | -         | nC         |
| <b>Drain-Source Diode Characteristics</b>            |              |   |     |       |           |            |
| Diode Forward Voltage <sup>(Note 3)</sup>            | $V_{SD}$     | $V_{GS}=0V, I_S=20A$  | -   | -     | 1.2       | V          |
| Diode Forward Current <sup>(Note 2)</sup>            | $I_S$        |   | -   | -     | 20        | A          |
| Reverse Recovery Time                                | $t_{rr}$     | $T_J = 25^{\circ}\text{C}, I_F = 20A$<br>$di/dt = 100A/\mu s$ <sup>(Note 3)</sup> | -   | 29    | -         | nS         |
| Reverse Recovery Charge                              | $Q_{rr}$     |   | -   | 49    | -         | nC         |
| Forward Turn-On Time                                 | $t_{on}$     | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)              |     |       |           |            |

## Notes:

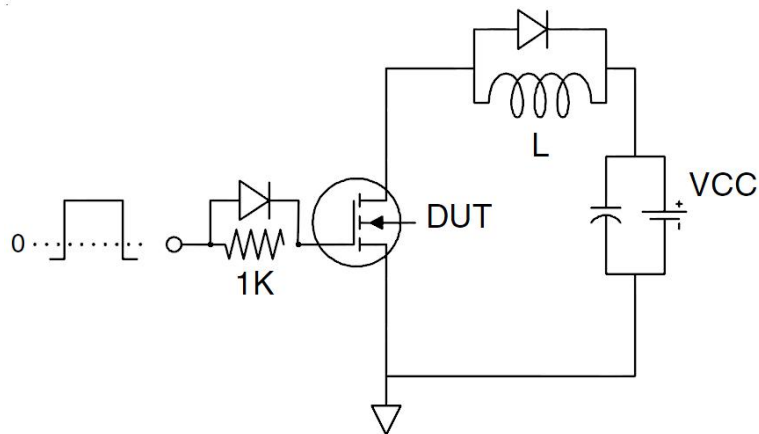
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board,  $t \leq 10$  sec.
3. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production
5. EAS condition:  $T_J=25^{\circ}\text{C}, V_{DD}=30V, V_G=10V, L=0.5\text{mH}, R_g=25\Omega$

## Test Circuit

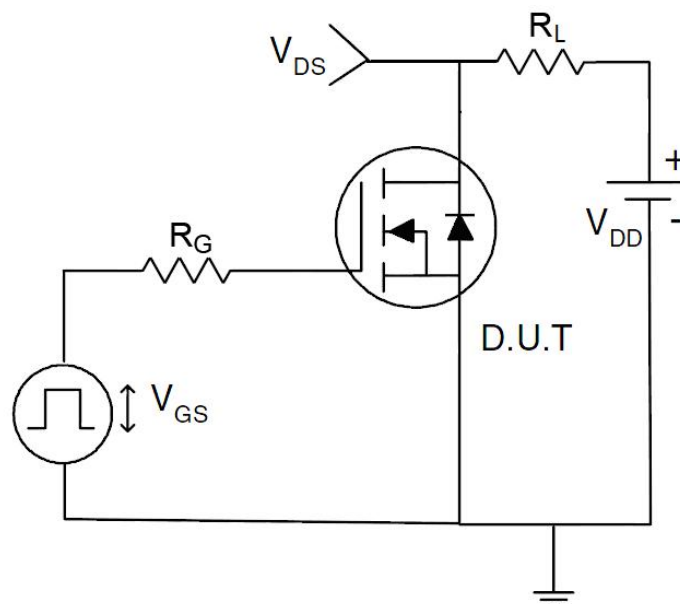
### 1) $E_{AS}$ test Circuit



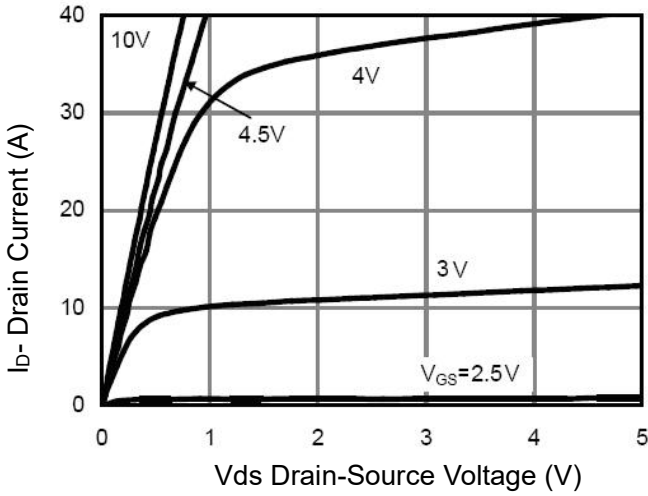
### 2) Gate charge test Circuit



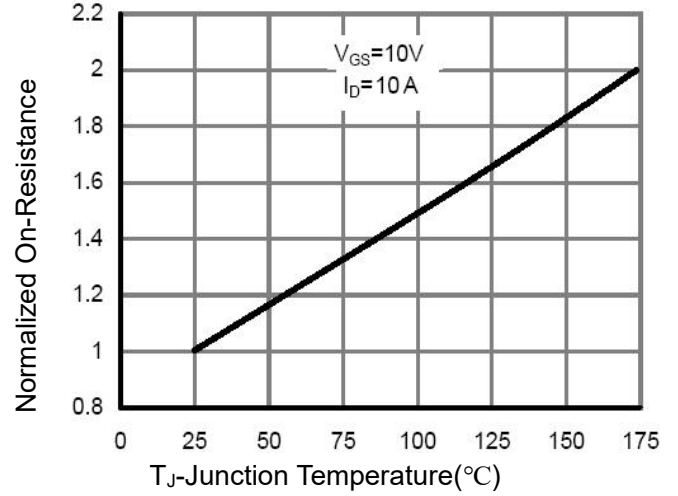
### 3) Switch Time Test Circuit



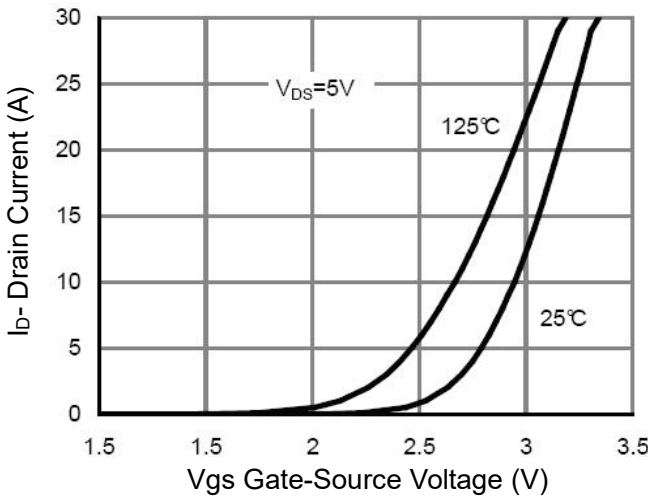
**Typical Electrical and Thermal Characteristics (Curves)**



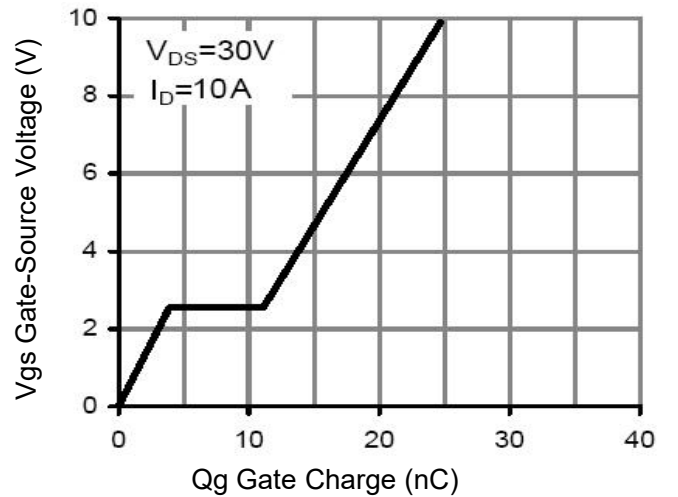
**Figure 1 Output Characteristics**



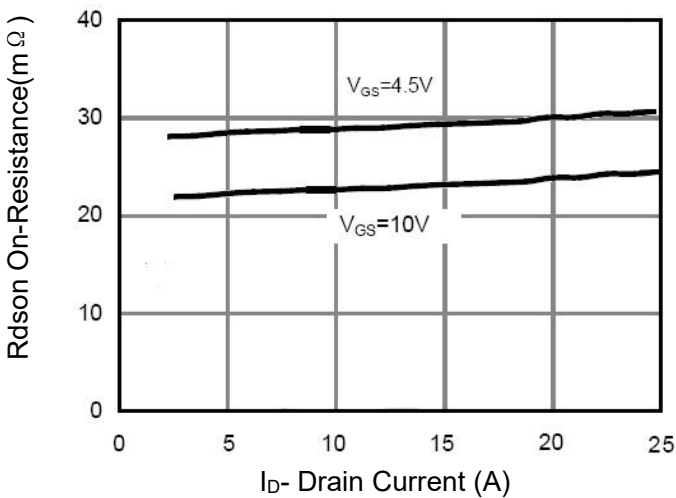
**Figure 4  $R_{ds(on)}$ -Junction Temperature**



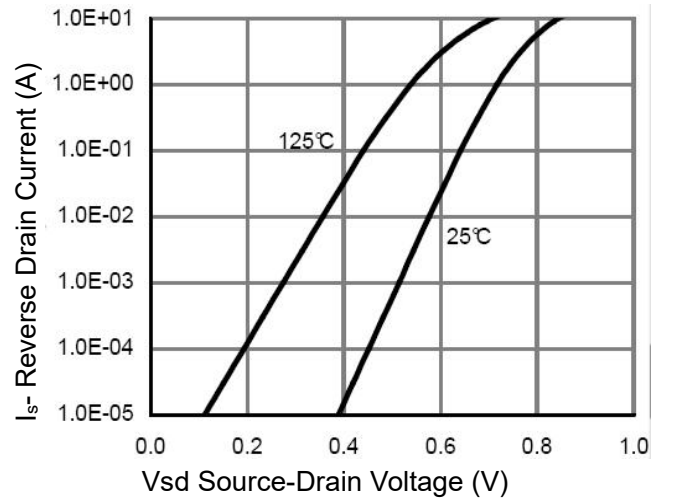
**Figure 2 Transfer Characteristics**



**Figure 5 Gate Charge**



**Figure 3  $R_{ds(on)}$ - Drain Current**



**Figure 6 Source- Drain Diode Forward**

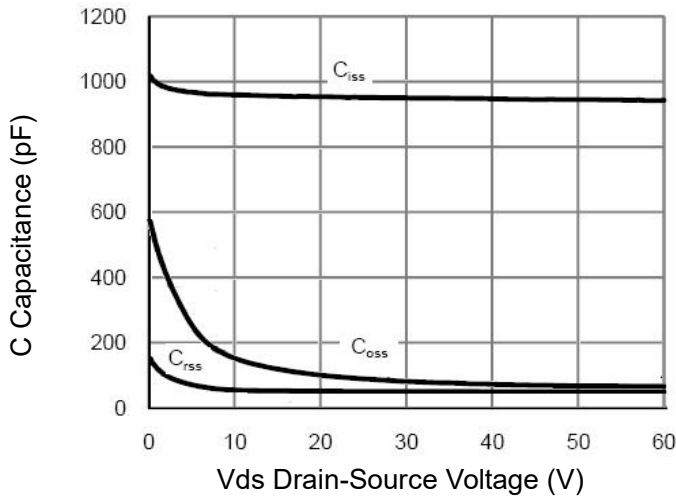


Figure 7 Capacitance vs Vds

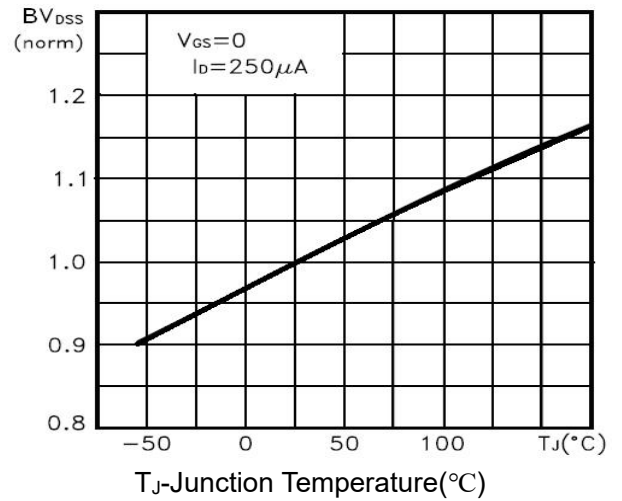


Figure 9  $BV_{DSS}$  vs Junction Temperature

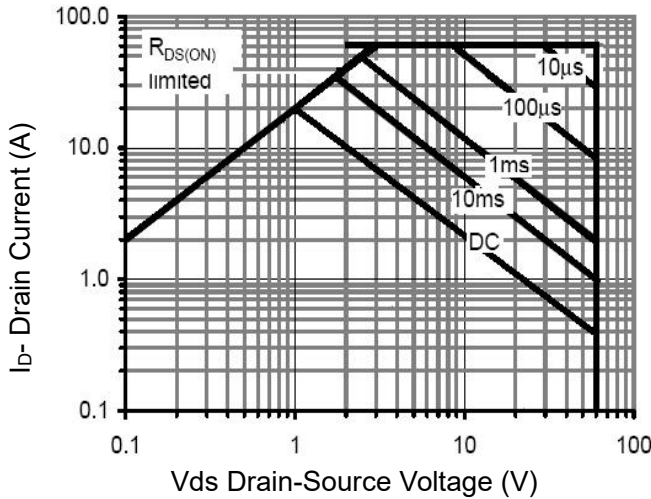


Figure 8 Safe Operation Area

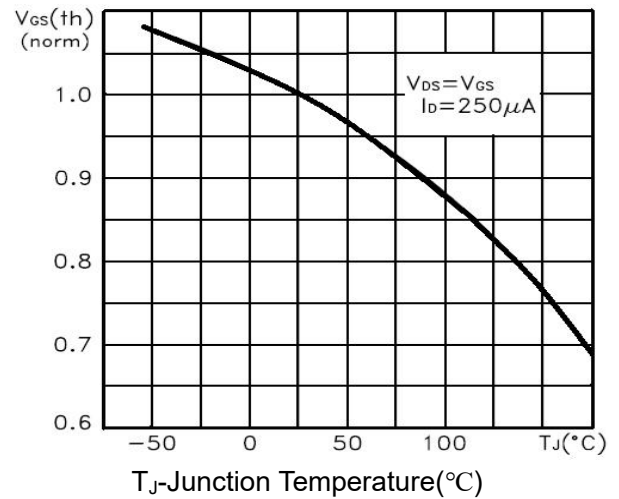


Figure 10  $V_{GS(th)}$  vs Junction Temperature

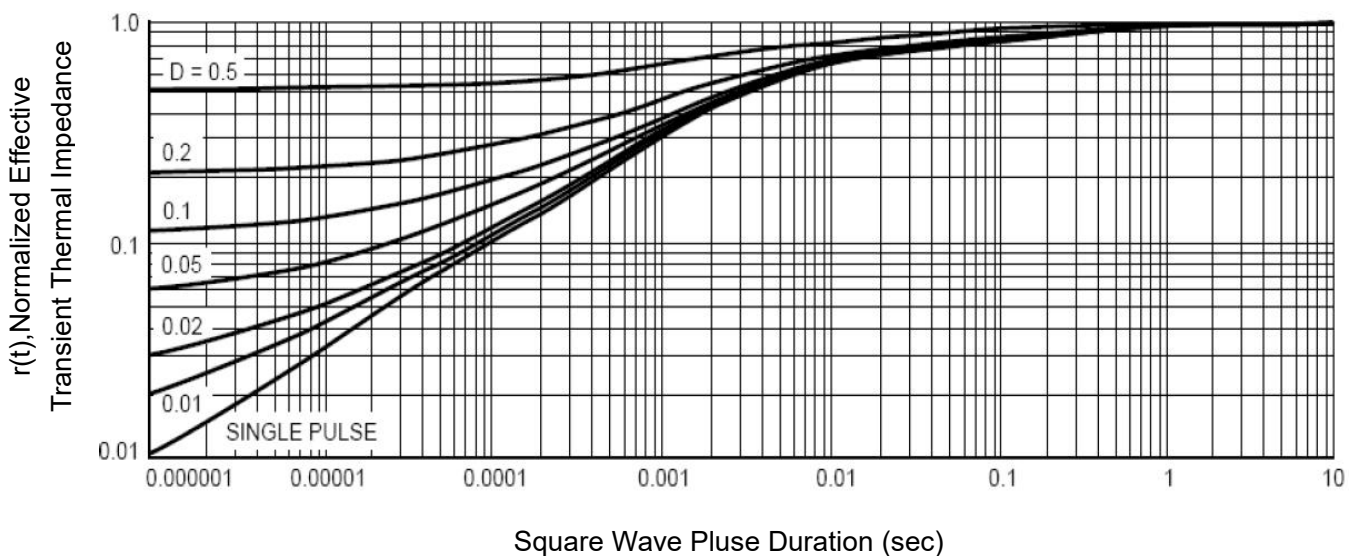
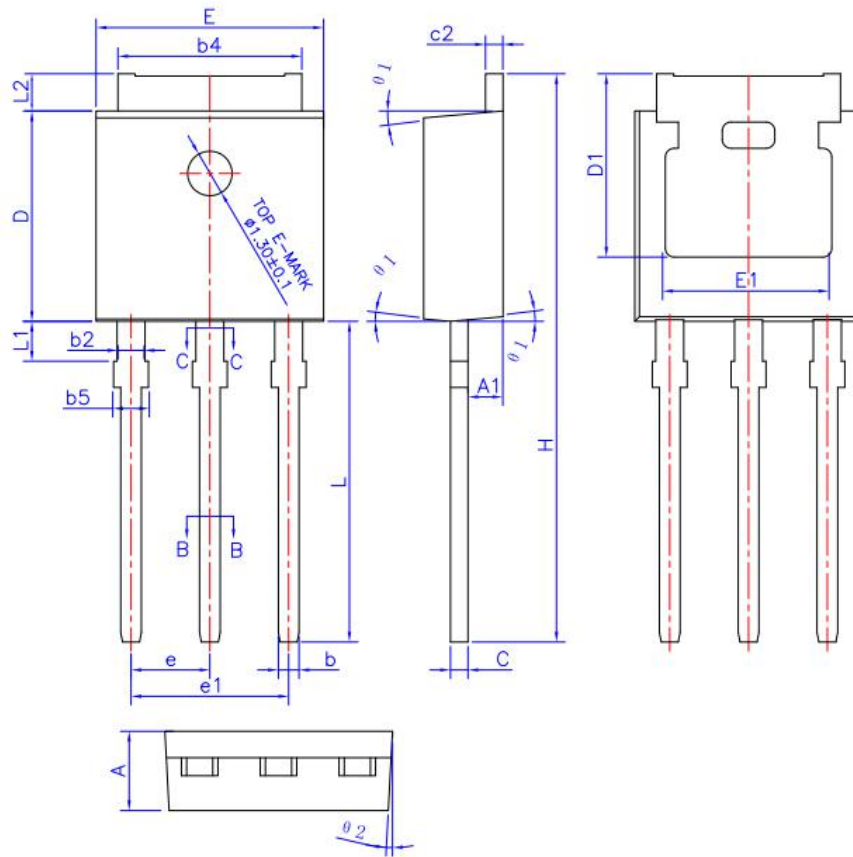


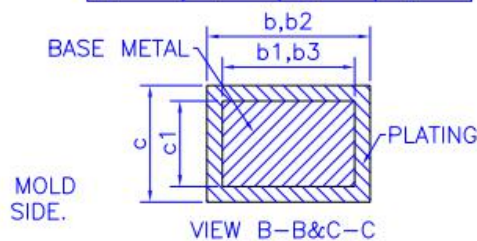
Figure 11 Normalized Maximum Transient Thermal Impedance

TO-251 Package Information



COMMON DIMENSIONS  
(UNITS OF MEASURE =MILLIMETER)

| SYMBOL     | MIN   | NOM   | MAX   |
|------------|-------|-------|-------|
| A          | 2.20  | 2.30  | 2.35  |
| A1         | 0.90  | 1.01  | 1.10  |
| b          | 0.56  | ---   | 0.69  |
| b1         | 0.55  | 0.60  | 0.65  |
| b2         | 0.77  | ---   | 0.90  |
| b3         | 0.76  | 0.81  | 0.86  |
| b4         | 5.23  | 5.33  | 5.43  |
| b5         | ---   | ---   | 1.05  |
| c          | 0.46  | ---   | 0.59  |
| c1         | 0.45  | 0.51  | 0.55  |
| c2         | 0.46  | ---   | 0.59  |
| D          | 6.00  | 6.10  | 6.20  |
| D1         | 5.20  | ---   | ---   |
| E          | 6.50  | 6.60  | 6.70  |
| E1         | 4.60  | 4.83  | 5.00  |
| e          | 2.24  | 2.29  | 2.34  |
| e1         | 4.47  | 4.57  | 4.67  |
| H          | 16.18 | 16.48 | 16.78 |
| L          | 9.00  | 9.30  | 9.60  |
| L1         | 0.95  | 1.16  | 1.35  |
| L2         | 0.90  | 1.08  | 1.25  |
| $\theta 1$ | 3°    | 5°    | 7°    |
| $\theta 2$ | 1°    | 3°    | 5°    |



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